

**Notice of References Cited**

Application/Control No.

10/528,681

Applicant(s)/Patent Under  
Reexamination  
VIGNOLI ET AL.

Examiner

Luke S. Wassum

Art Unit

2167

Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,861,881 A	01-1999	Freeman et al.	715/201
*	B	US-2002/0059584 A1	05-2002	Ferman et al.	725/34
*	C	US-2003/0061610 A1	03-2003	Errico, James H.	725/46
*	D	US-2003/0121040 A1	06-2003	Ferman et al.	725/40
*	E	US-2003/0206710 A1	11-2003	Ferman et al.	386/46
*	F	US-2004/0261095 A1	12-2004	Sezan et al.	725/025
*	G	US-2004/0267805 A1	12-2004	Sezan et al.	707/102
*	H	US-2004/0268383 A1	12-2004	Sezan et al.	725/025
*	I	US-2004/0268389 A1	12-2004	Sezan et al.	725/035
*	J	US-2004/0268390 A1	12-2004	Ibrahim Sezan et al.	725/035
*	K	US-2004/0255150 A1	12-2004	Sezan et al.	713/200
*	L	US-2005/0060641 A1	03-2005	Sezan et al.	715/500.1
*	M	US-2005/0091685 A1	04-2005	Sezan et al.	725/046

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No. 10/528,681	Applicant(s)/Patent Under Reexamination VIGNOLI ET AL.	
		Examiner Luke S. Wassum	Art Unit 2167	Page 2 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0091686 A1	04-2005	Sezan et al.	725/046
*	B	US-2005/0091165 A1	04-2005	Sezan et al.	705/052
*	C	US-2005/0120034 A1	06-2005	Sezan et al.	707/100
*	D	US-2005/0131727 A1	06-2005	Sezan et al.	705/001
*	E	US-2005/0141864 A1	06-2005	Sezan et al.	386/069
*	F	US-2005/0120033 A1	06-2005	Sezan et al.	707/100
*	G	US-2005/0188328 A1	08-2005	Sezan et al.	715/789
*	H	US-2006/0010240 A1	01-2006	Chuah, Mei	709/228
*	I	US-7,055,168 B1	05-2006	Erico et al.	725/46
*	J	US-7,181,691 B2	02-2007	Sezan et al.	715/719
*	K	US-7,178,107 B2	02-2007	Sezan et al.	715/719
*	L	US-7,194,688 B2	03-2007	Sezan et al.	715/719
*	M	US-7,194,687 B2	03-2007	Sezan et al.	715/719

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>	Application/Control No. 10/528,681	Applicant(s)/Patent Under Reexamination VIGNOLI ET AL.	
	Examiner Luke S. Wassum	Art Unit 2167	Page 3 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,197,709 B2	03-2007	Sezan et al.	715/719
*	B	US-7,424,678 B2	09-2008	Sezan et al.	715/719
*	C	US-7,424,677 B2	09-2008	Sezan et al.	715/719
*	D	US-7,509,580 B2	03-2009	Sezan et al.	715/719
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.